## Notic of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination CHANG ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	4	US-5,921,689	07-1999	Buckby et al.	400/225
	В	US-4,034,635	07-1977	Woolston, Allan Brent	83/38
	С	US-6,568,323	05-2003	Tokiwa, Shizurou	101/227
·	D	US-5,458,062	10-1995	Goldberg et al.	101/485
	E	US-6,354,214	03-2002	Tokiwa, Shizurou	101/484
	F	US-6,018,687	01-2000	Tabor, Keith A.	700/125
	G	US-4,163,405	08-1979	Diesch et al.	83/371
	Ι	US-4,960,336	10-1990	Brooks et al.	400/61
	ı	US-			
	7	US-			
	K.	US-			
	L	US-		7.00	
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0.					
	Р					
	Q					
	R					
	S					
	Т			-		<u> </u>

## **NON-PATENT DOCUMENTS**

*	<u> </u>	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
·	U						
	V						
	w						
	x						

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.